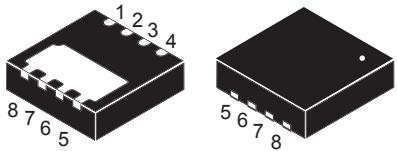


N-channel 600 V, 1.5 Ω typ., 2.2 A MDmesh II Power MOSFET in a PowerFLAT 3.3x3.3 HV package

Features



PowerFLAT 3.3x3.3 HV

Order code	V _{DS}	R _{DS(on)} max.	I _D
STL3NM60N	600 V	1.8 Ω	2.2 A

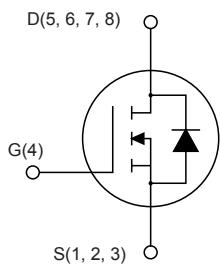
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

Applications

- Switching applications

Description

This device is an N-channel Power MOSFET developed using the second generation of MDmesh technology. This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.



AM15810v1



Product status link	
STL3NM60N	
Product summary	
Order code	STL3NM60N
Marking	3NM60
Package	PowerFLAT 3.3x3.3 HV
Packing	Tape and reel

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	600	V
V _{GS}	Gate-source voltage	±25	V
I _D	Drain current (continuous) at T _C = 25 °C	2.2	A
	Drain current (continuous) at T _C = 100 °C	1.7	
	Drain current (continuous) at T _A = 25 °C	0.65	
	Drain current (continuous) at T _A = 100 °C	0.5	
I _{DM} ⁽¹⁾	Drain current pulsed	2.6	A
P _{TOT}	Total power dissipation at T _A = 25 °C	2	W
	Total power dissipation at T _C = 25 °C	22	W
I _{AS}	Avalanche current, repetitive or non-repetitive (pulse width limited by T _J max)	1	A
E _{AS}	Single pulse avalanche energy (starting T _J = 25 °C, I _D = I _{AS} , V _{DD} = 50 V)	119	mJ
dV/dt ⁽²⁾	Peak diode recovery voltage slope	15	V/ns
T _J	Operating junction temperature range	-55 to 150	°C
T _{stg}	Storage temperature range		°C

1. Pulse width is limited by safe operating area.

2. I_{SD} ≤ 2.2 A, dI/dt ≤ 400 A/μs, V_{DS} (peak) ≤ V_{(BR)DSS}, V_{DD} = 80% V_{(BR)DSS}.

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R _{thJC}	Thermal resistance, junction-to-case	5.6	°C/W
R _{thJA} ⁽¹⁾	Thermal resistance, junction-to-ambient	62.5	°C/W

1. When mounted on an 1-inch² FR-4, 2 Oz copper board, t < 10 s.

2 Electrical characteristics

$T_C = 25^\circ\text{C}$ unless otherwise specified.

Table 3. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	600			V
I_{DSS}	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$		1		μA
		$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}, T_C = 125^\circ\text{C}$ ⁽¹⁾			100	
I_{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			± 100	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	2	3	4	V
$R_{\text{DS(on)}}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 1 \text{ A}$		1.5	1.8	Ω

1. Defined by design, not subject to production test.

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input capacitance	$V_{DS} = 50 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$	-	188	-	pF
C_{oss}	Output capacitance		-	13	-	pF
C_{rss}	Reverse transfer capacitance		-	1.1	-	pF
$C_{\text{oss eq.}}$ ⁽¹⁾	Equivalent capacitance energy related	$V_{DS} = 0 \text{ to } 480 \text{ V}, V_{GS} = 0 \text{ V}$	-	100	-	pF
R_G	Intrinsic gate resistance	$f = 1 \text{ MHz}$ open drain	-	6	-	Ω
Q_g	Total gate charge	$V_{DD} = 480 \text{ V}, I_D = 2.2 \text{ A}$	-	9.5	-	nC
Q_{gs}	Gate-source charge	$V_{GS} = 0 \text{ to } 10 \text{ V}$	-	1.6	-	nC
Q_{gd}	Gate-drain charge	(see Figure 14. Test circuit for gate charge behavior)	-	5.3	-	nC

1. $C_{\text{oss eq.}}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(\text{on})}$	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 1.1 \text{ A}, R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$	-	8.6	-	ns
t_r	Rise time		-	6.2	-	ns
$t_{d(\text{off})}$	Turn-off delay time		-	20.8	-	ns
t_f	Fall time		-	20	-	ns

Table 6. Source-drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain current		-		2.2	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		2.6	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 2.2 \text{ A}, V_{GS} = 0 \text{ V}$	-		1.6	V
t_{rr}	Reverse recovery time	$I_{SD} = 2.2 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s},$ $V_{DD} = 60 \text{ V}$	-	168		ns
Q_{rr}	Reverse recovery charge	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	672		nC
I_{RRM}	Reverse recovery current		-	8		A
t_{rr}	Reverse recovery time	$I_{SD} = 2.2 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s},$ $V_{DD} = 60 \text{ V}, T_J = 150 \text{ }^\circ\text{C}$	-	2.3		ns
Q_{rr}	Reverse recovery charge	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	913		nC
I_{RRM}	Reverse recovery current		-	9		A

1. Pulse width is limited by safe operating area.
2. Pulsed: pulse duration = 300 μs , duty cycle 1.5%.

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

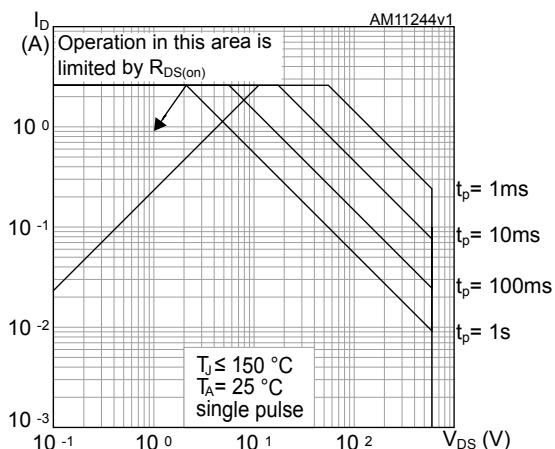


Figure 2. Normalized transient thermal impedance

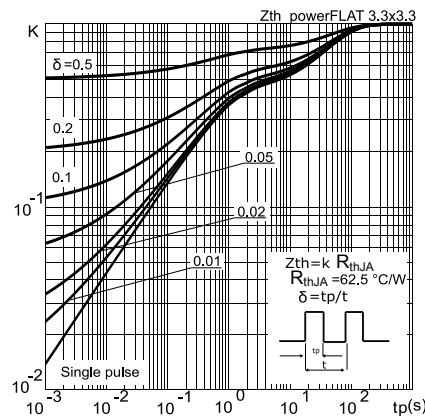


Figure 3. Typical output characteristics

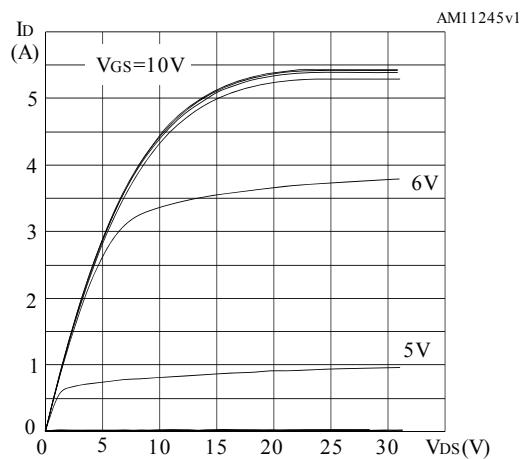


Figure 4. Typical transfer characteristics

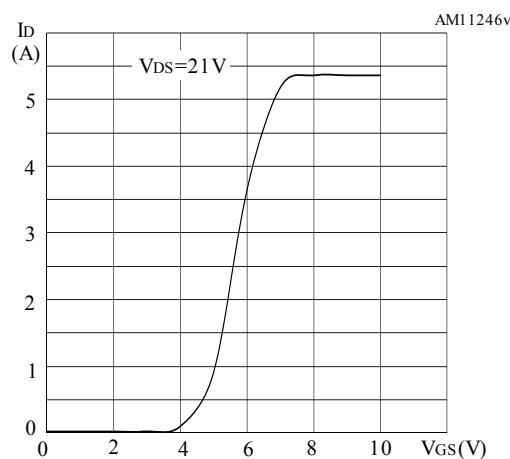


Figure 5. Typical gate charge characteristics

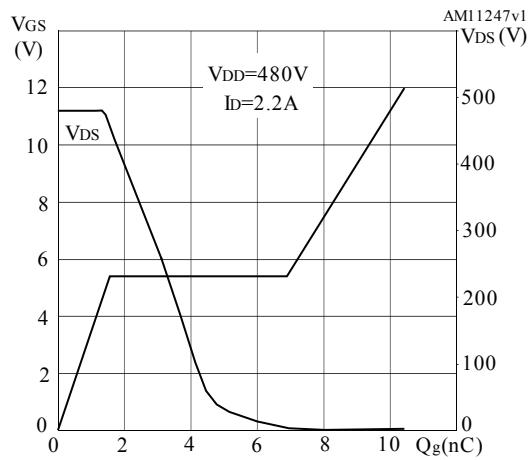


Figure 6. Typical drain-source on-resistance

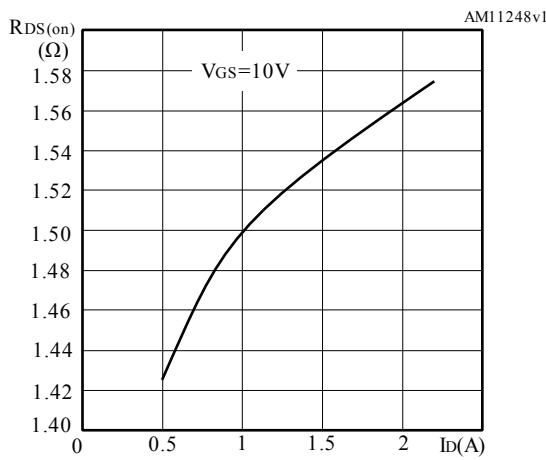
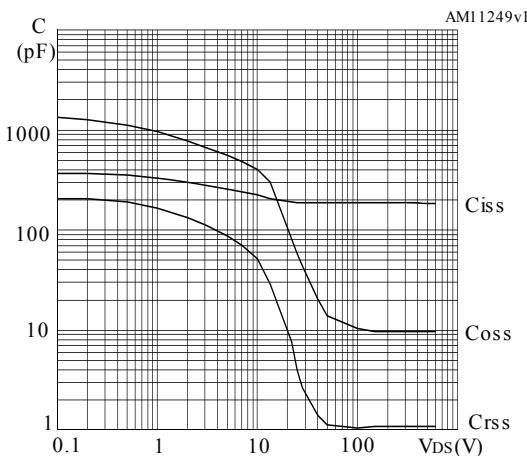
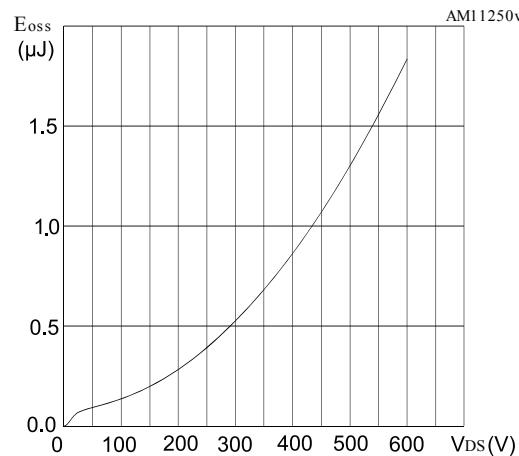
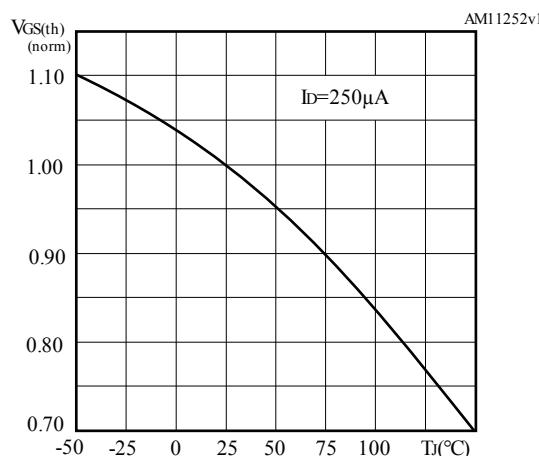
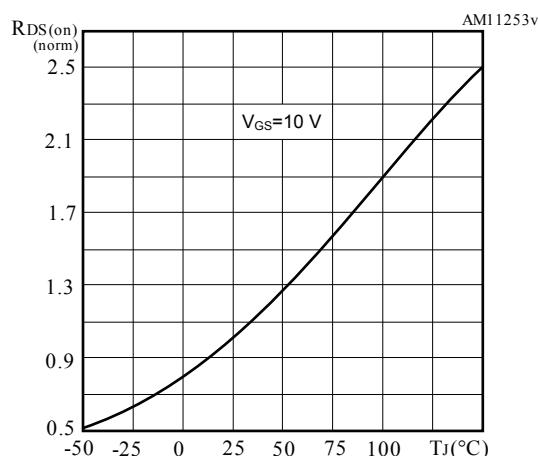
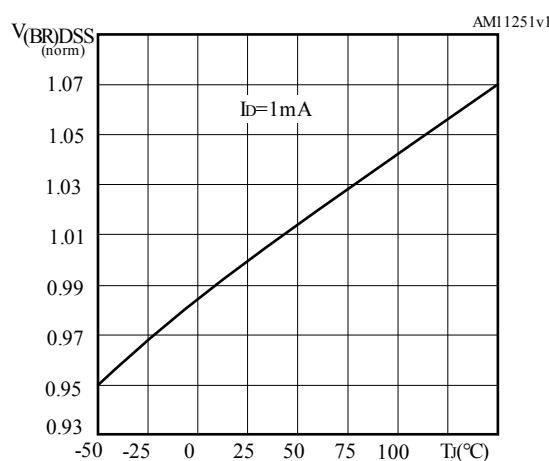
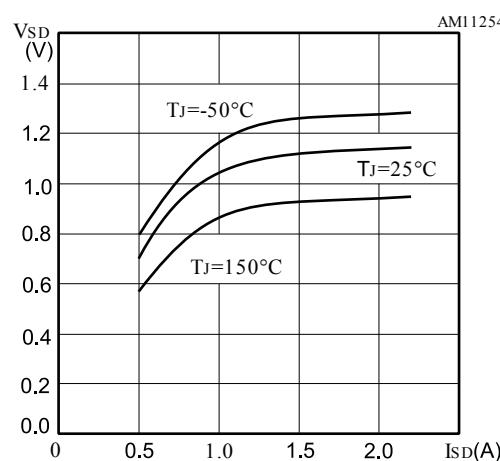
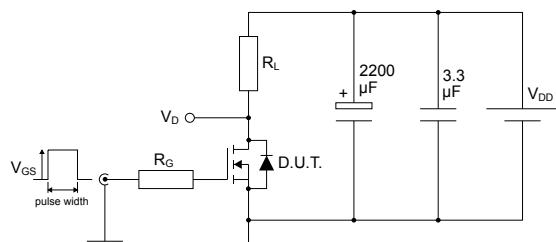


Figure 7. Typical capacitance characteristics

Figure 8. Typical output capacitance stored energy

Figure 9. Normalized gate threshold vs temperature

Figure 10. Normalized on-resistance vs temperature

Figure 11. Normalized breakdown voltage vs temperature

Figure 12. Typical reverse diode forward characteristics


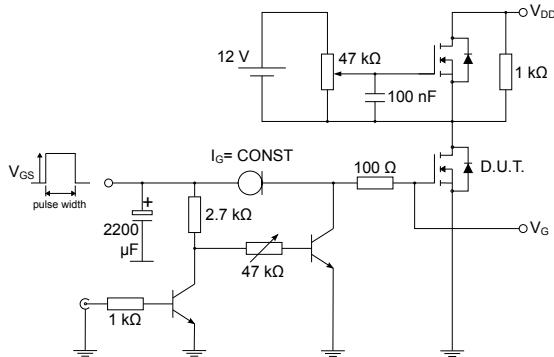
3 Test circuits

Figure 13. Test circuit for resistive load switching times



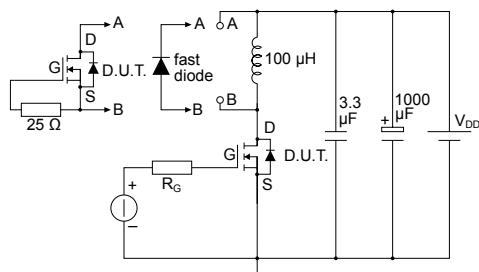
AM01468v1

Figure 14. Test circuit for gate charge behavior



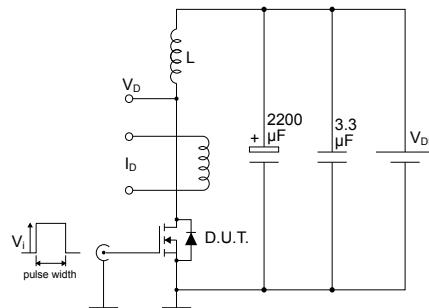
AM01469v1

Figure 15. Test circuit for inductive load switching and diode recovery times



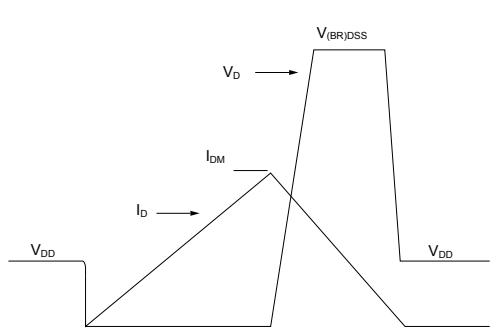
AM01470v1

Figure 16. Unclamped inductive load test circuit



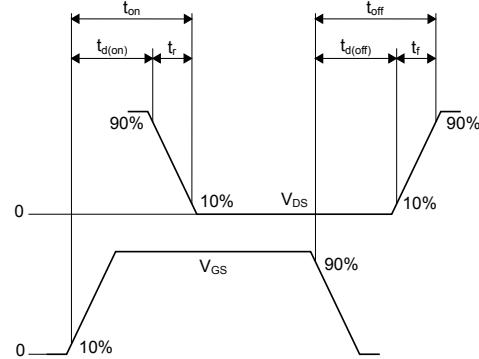
AM01471v1

Figure 17. Unclamped inductive waveform



AM01472v1

Figure 18. Switching time waveform



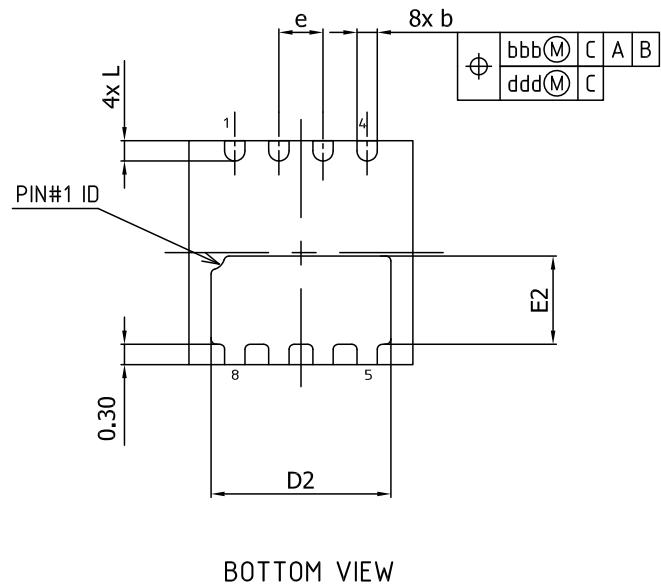
AM01473v1

4 Package information

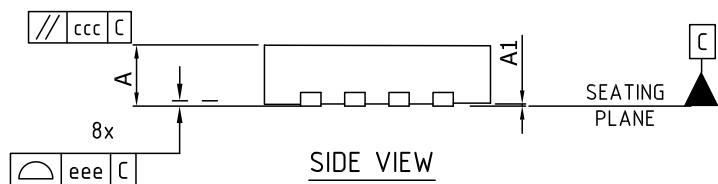
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 PowerFLAT 3.3x3.3 HV package information

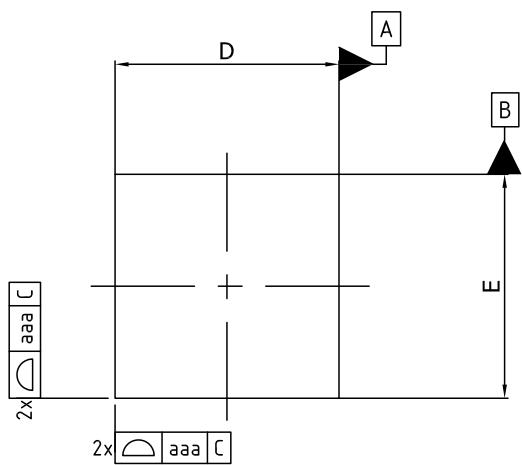
Figure 19. PowerFLAT 3.3x3.3 HV package outline



BOTTOM VIEW



SIDE VIEW

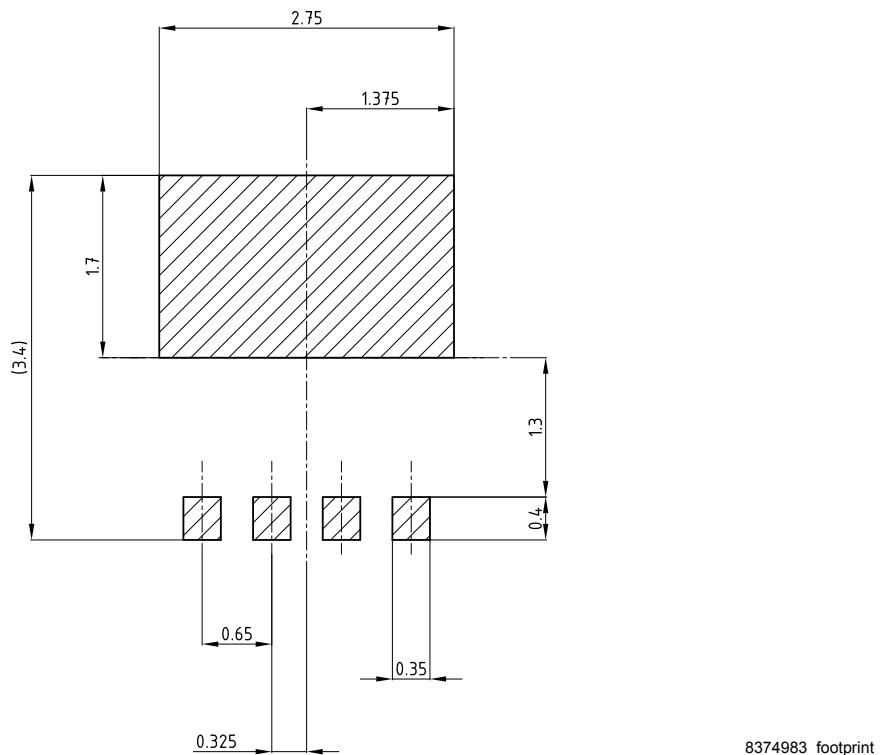


TOP VIEW

8374983_Rev_2

Table 7. PowerFLAT 3.3x3.3 HV package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.80	0.90	1.00
A1	0	0.02	0.05
b	0.25	0.30	0.40
D		3.30	
D2	2.50	2.65	2.75
E		3.30	
E2	1.15	1.30	1.40
e		0.65	
L	0.20	0.30	0.40
aaa		0.10	
bbb		0.10	
ccc		0.10	
ddd		0.05	
eee		0.08	

Figure 20. PowerFLAT 3.3x3.3 HV recommended footprint (dimensions are in mm)

8374983_footprint

Revision history

Table 8. Document revision history

Date	Version	Changes
12-Mar-2012	1	First release.
19-Nov-2014	2	<p>Document status changed from preliminary to production data.</p> <p>Updated <i>Figure 1.: Internal schematic diagram</i>, <i>Figure 2.: Safe operating area</i>, <i>Figure 3.: Thermal impedance</i> and <i>Figure 12.: Normalized $V_{(BR)DSS}$ vs temperature</i>.</p> <p>Updated <i>Table 5.: Dynamic</i> and <i>Table 7.: Source drain diode</i>.</p> <p>Minor text changes.</p>
26-May-2022	3	<p>Modified marking on cover page</p> <p>Updated <i>Figure 1. Safe operating area</i></p> <p>Modified I_{SDM} value in <i>Table 6. Source-drain diode</i></p> <p>Updated <i>Section 4.1 PowerFLAT 3.3x3.3 HV package information</i></p> <p>Minor text changes.</p>

Contents

1	Electrical ratings	2
2	Electrical characteristics.....	3
2.1	Electrical characteristics (curves)	5
3	Test circuits	7
4	Package information.....	8
4.1	PowerFLAT 3.3x3.3 HV package information	9
	Revision history	11

IMPORTANT NOTICE – READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgment.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. For additional information about ST trademarks, refer to www.st.com/trademarks. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2022 STMicroelectronics – All rights reserved